## Search Notes


Application/Control No.	Applicant(s)/Patent Under Reexamination
10655094	QIU ET AL.
Examiner	Art Unit
/BINH K TIEU/	2614

SEARCHED				
Class	Subclass	Date	Examiner	
379	1.01	03/02/2008	BKT	
379	1.03-1.04	03/02/2008	BKT	
379	9	03/02/2008	BKT	
379	10.01	03/02/2008	BKT	
379	15.01	03/02/2008	BKT	
379	22.02	03/02/2008	BKT	
379	23	03/02/2008	BKT	
379	27.01	03/02/2008	BKT	
379	27.03	03/02/2008	BKT	
379	27.08	03/02/2008	BKT	
379	29.01	03/02/2008	BKT	
379	32.04	03/02/2008	BKT	
375	243, 245, 260, 316	03/02/2008	BKT	
341	155-156	03/02/2008	BKT	
341	158	03/02/2008	BKT	

SEARCH NOTES				
Search Notes	Date	Examiner		
WEST DATABASES SEARCHES	03/02/2008	BKT		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
379	1.03-1.04	03/02/2008	BKT		
379	22.02	03/02/2008	BKT		
375	316	03/02/2008	BKT		
375	243	03/02/2008	BKT		
375	245	03/02/2008	BKT		
375	260	03/02/2008	BKT		

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